

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/801,867	OTSUKA ET AL.	
Examiner	Art Unit	
Nguyen T. Ha	2831	

SEARCHED				
Class	Subclass	Date	Examiner	
361	306.3	8/16/2006	NH	
	306.2			
	301.4			
	302-305			
174	75R			
257	698			
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCI	DTES H STRATEGY	)
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EAST SEARCH (SEE SEARCH HISTORY)	8/16/2006	NH
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